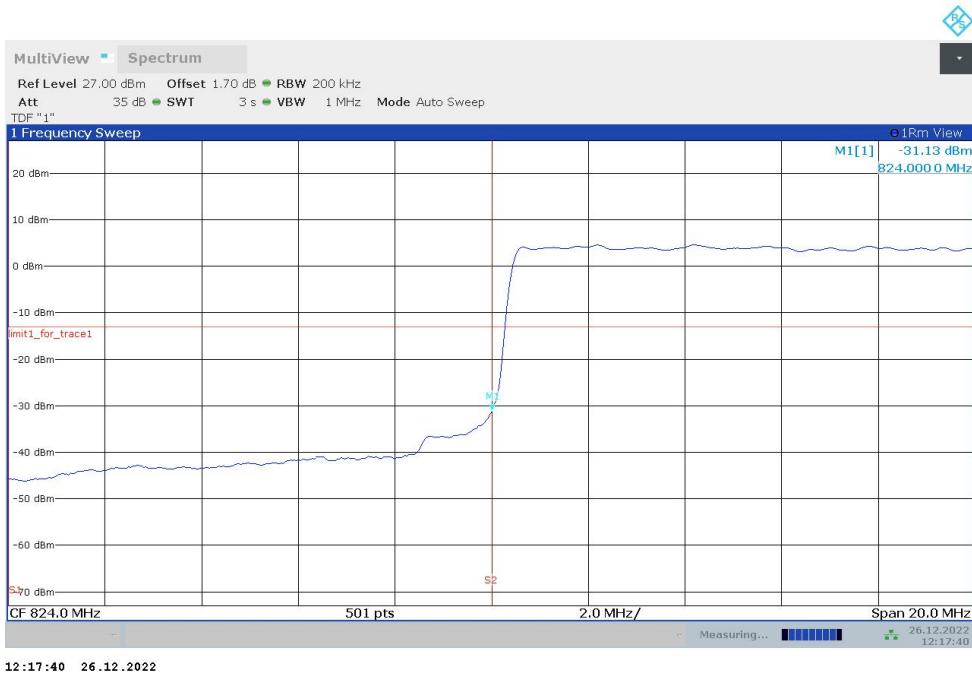
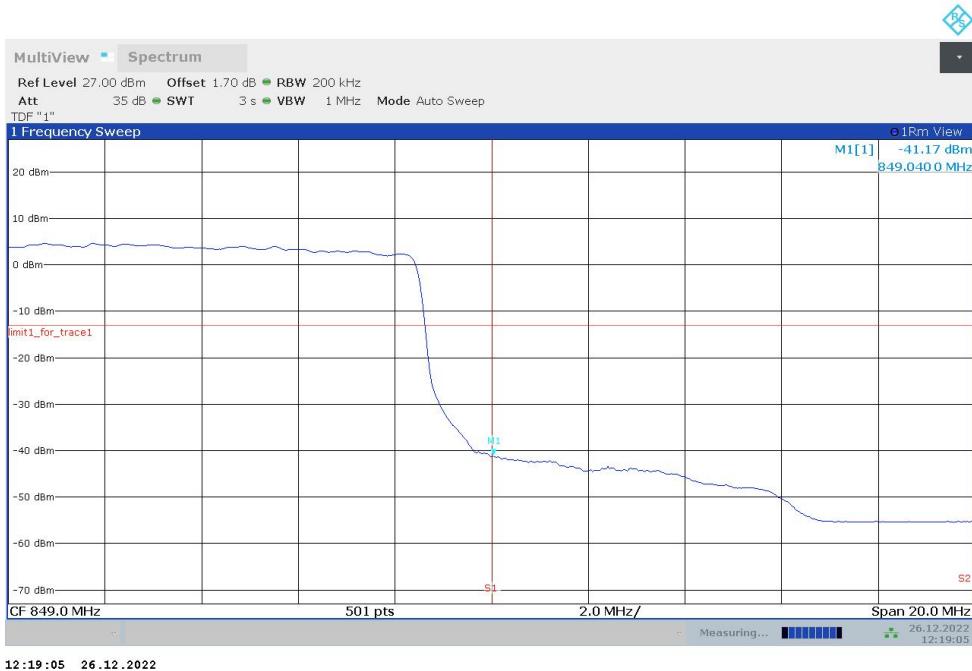
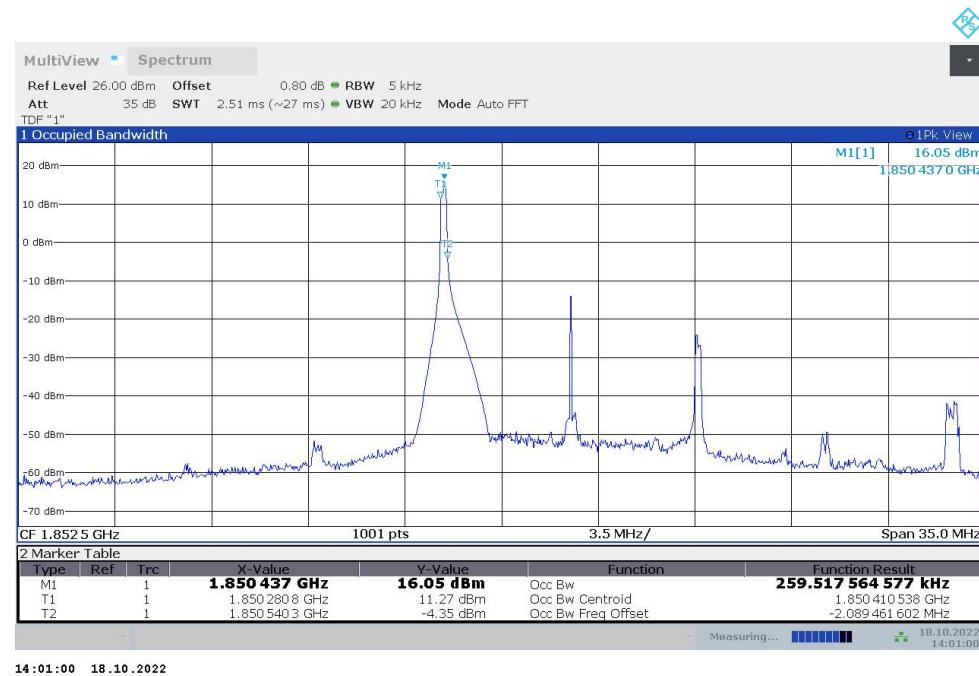
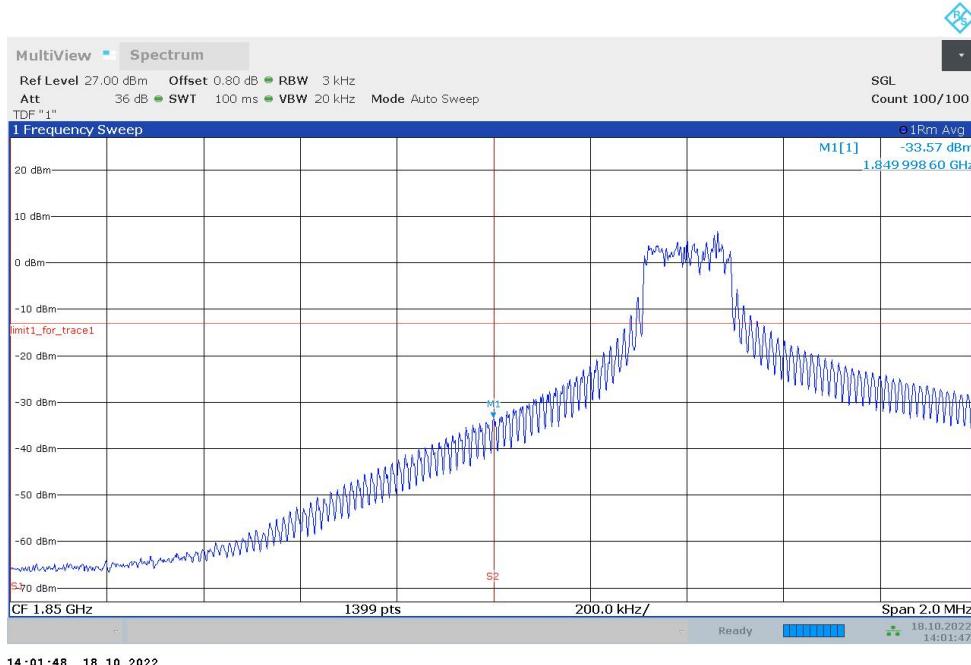


LOW BAND EDGE BLOCK-20M-100%RB

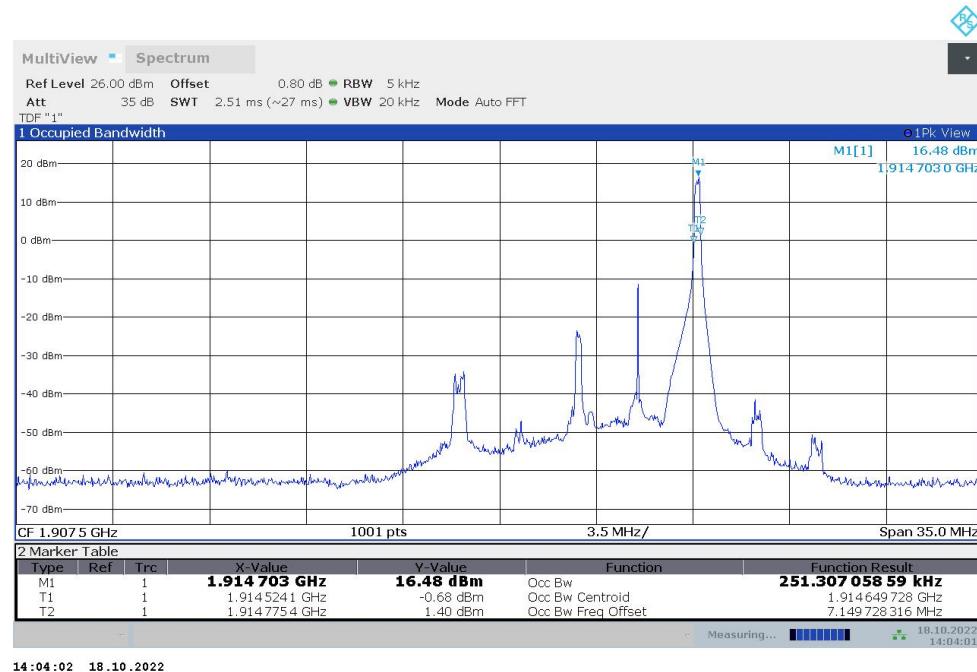


HIGH BAND EDGE BLOCK-20M-100%RB

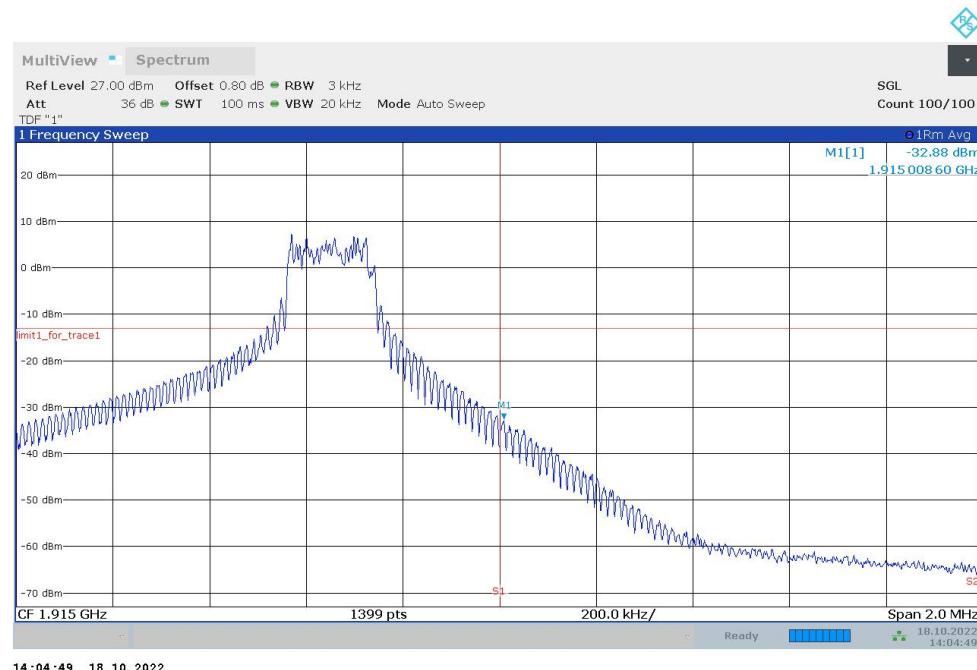


NR n25
OBW: 1RB-LOW_offset

LOW BAND EDGE BLOCK-1RB-LOW_offset


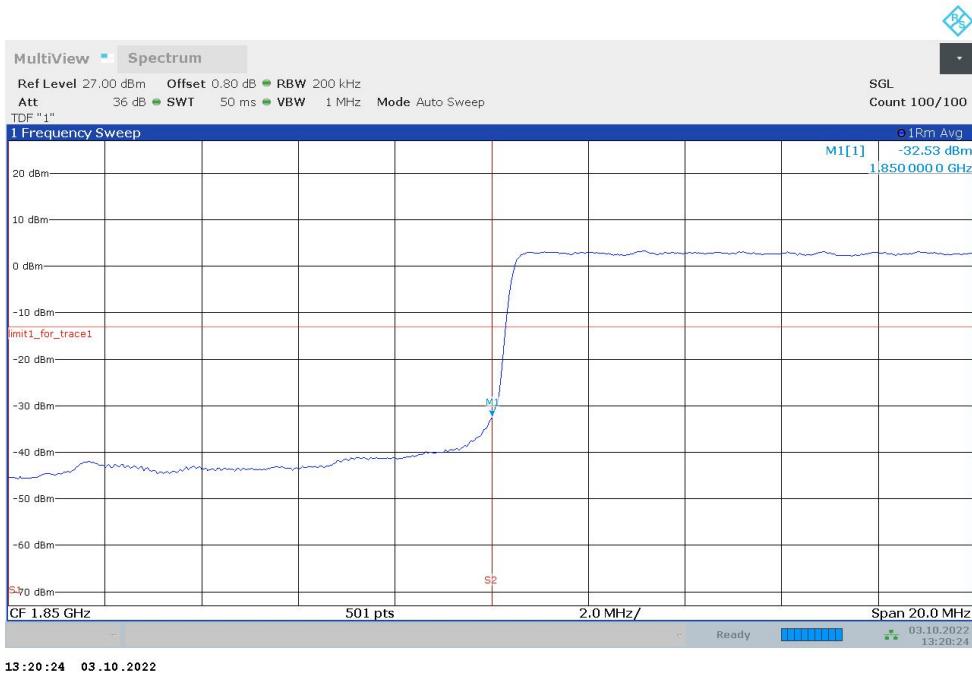
OBW: 1RB-HIGH_offset



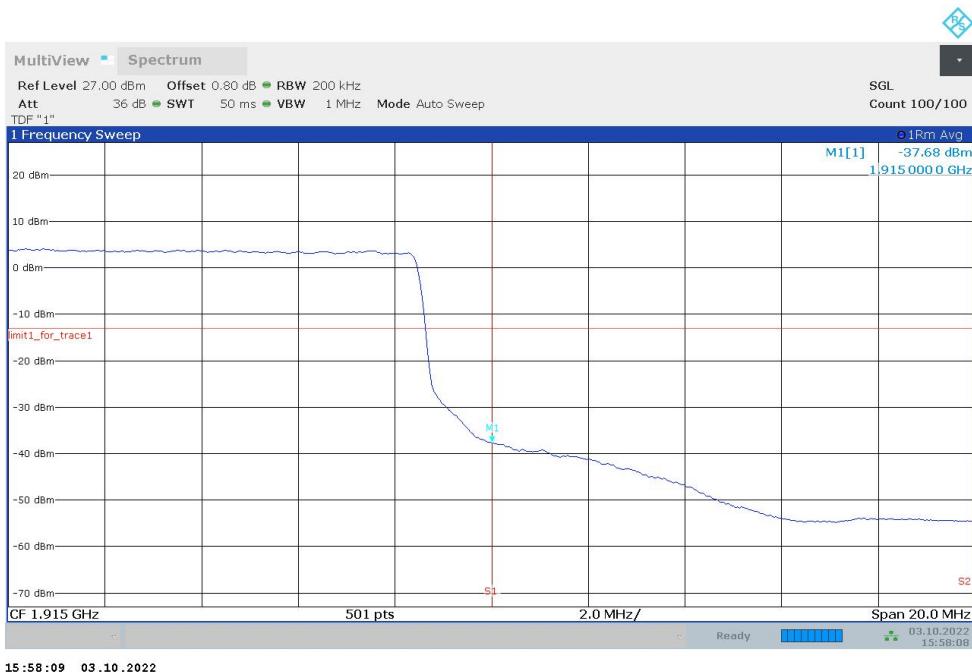
HIGH BAND EDGE BLOCK-1RB-HIGH_offset

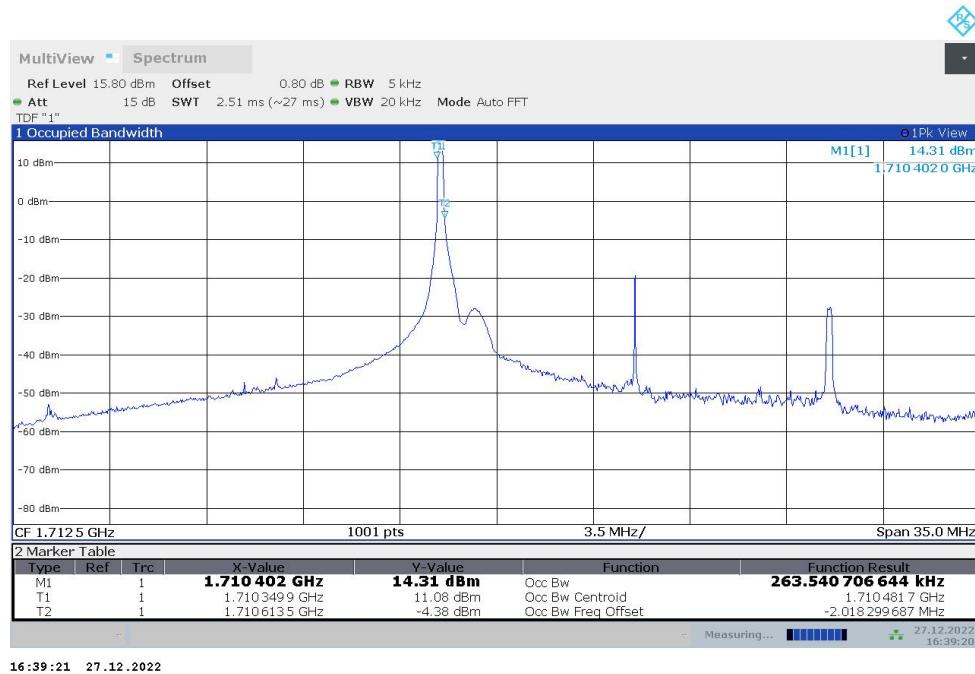
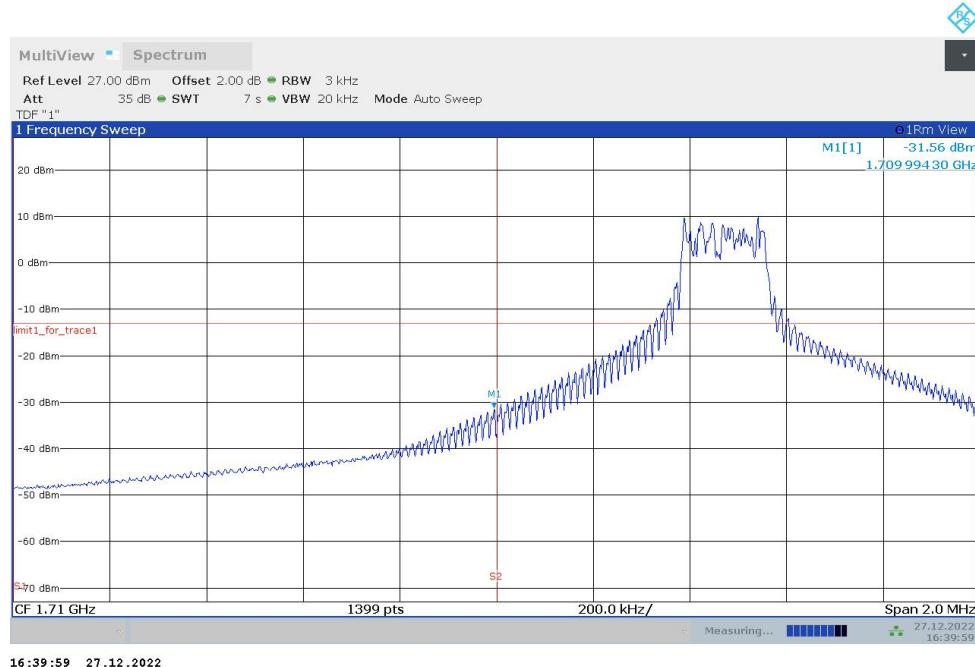


LOW BAND EDGE BLOCK-20M-100%RB

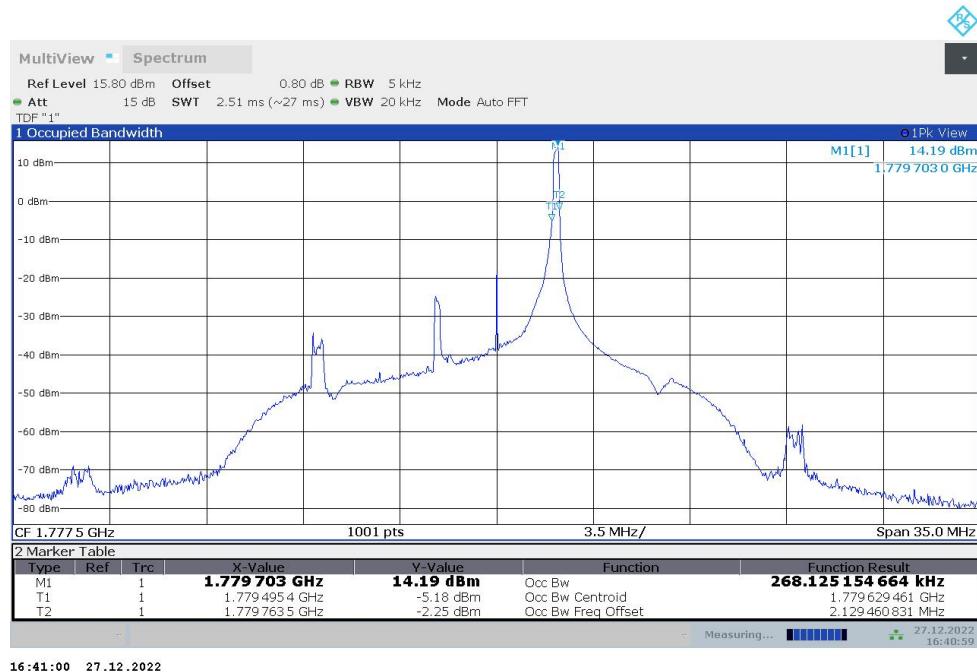


HIGH BAND EDGE BLOCK-20M-100%RB

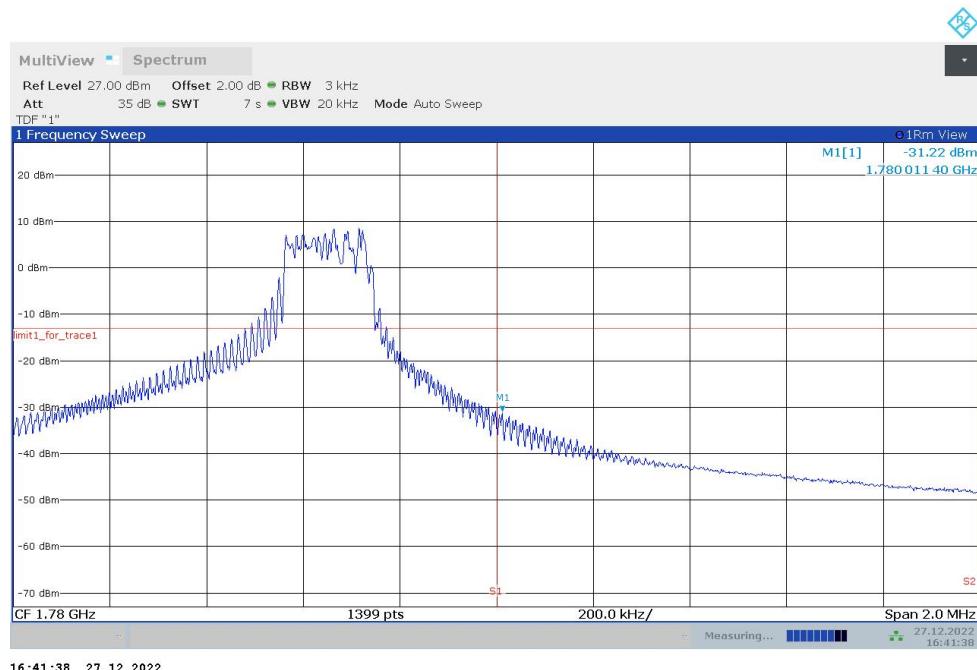


LTE Band 5+NR n66
OBW: 1RB-LOW_offset

LOW BAND EDGE BLOCK-1RB-LOW_offset


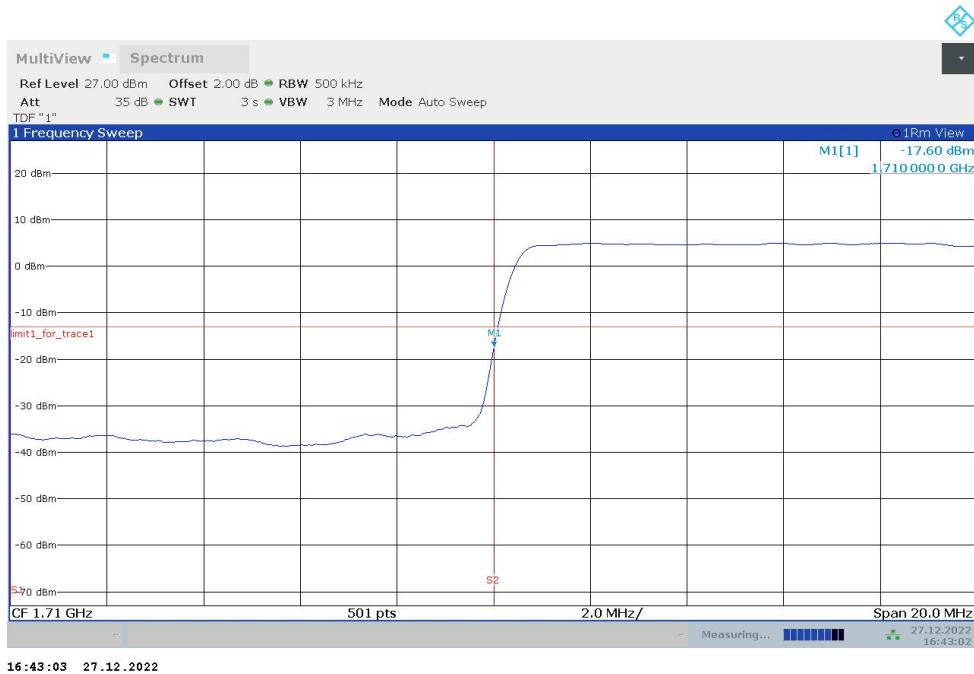
OBW: 1RB-HIGH_offset



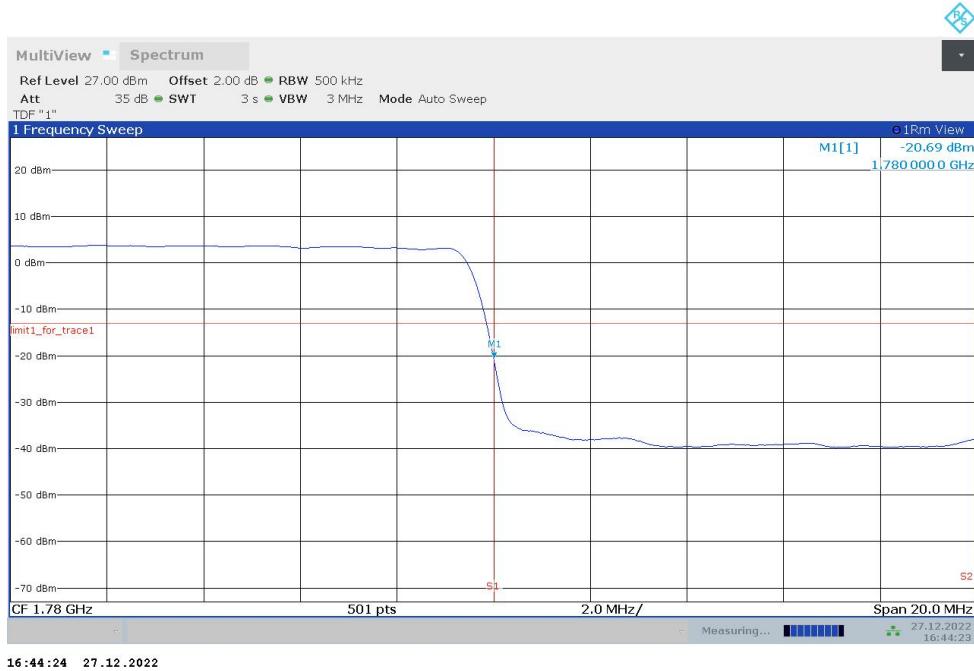
HIGH BAND EDGE BLOCK-1RB-HIGH_offset



LOW BAND EDGE BLOCK-40M-100%RB

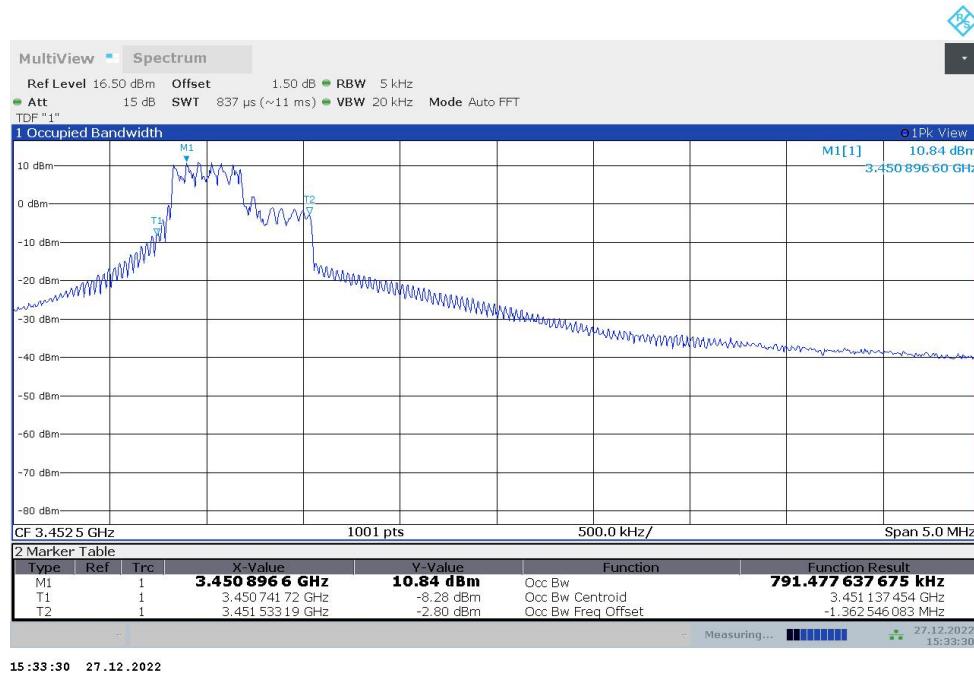


HIGH BAND EDGE BLOCK-40M-100%RB

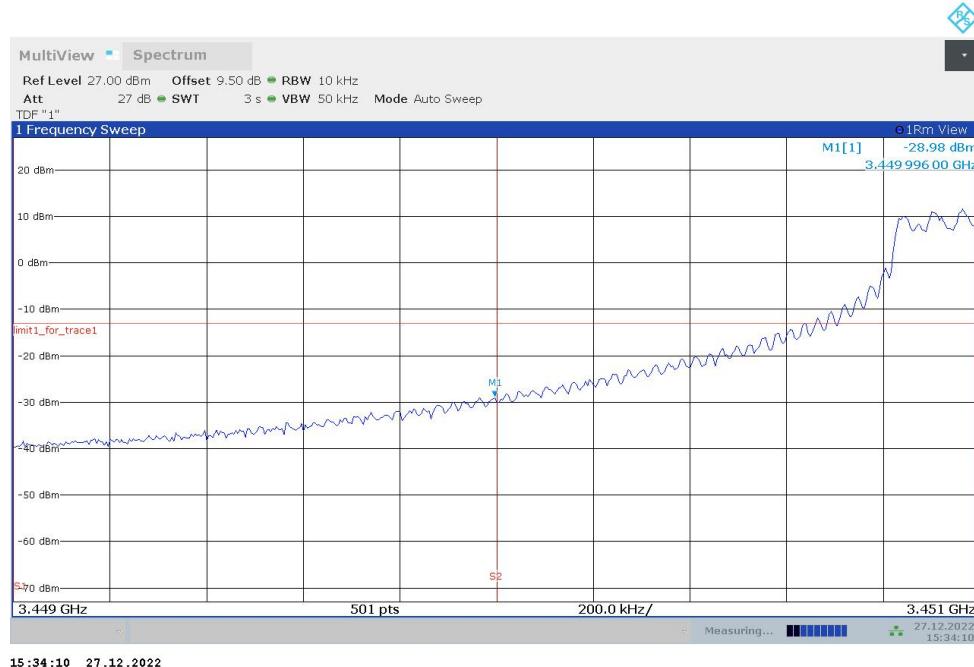


LTE Band 66+NR n77L

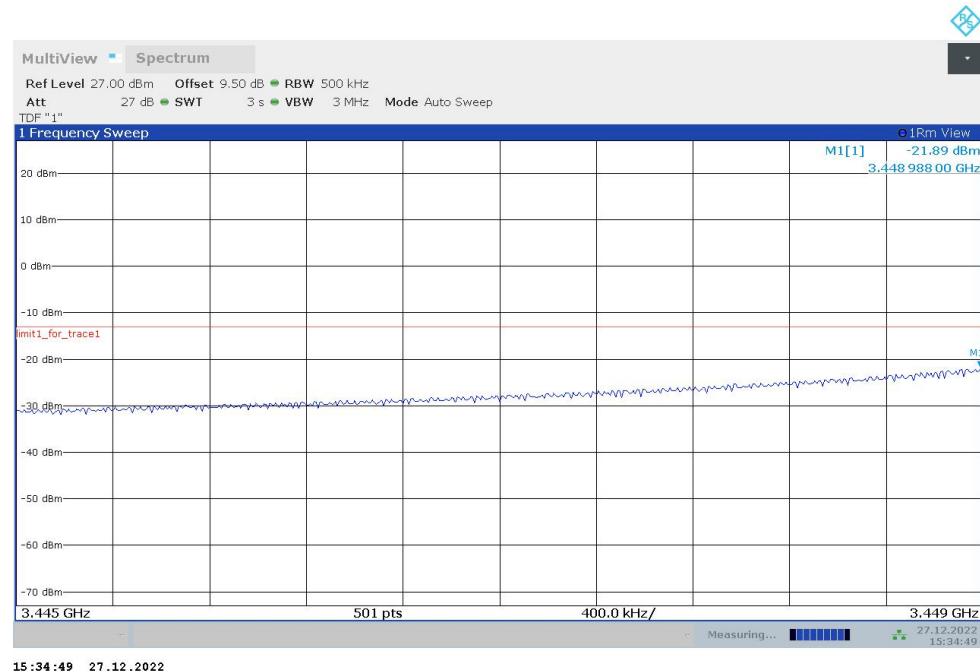
OBW: 1RB-LOW_offset



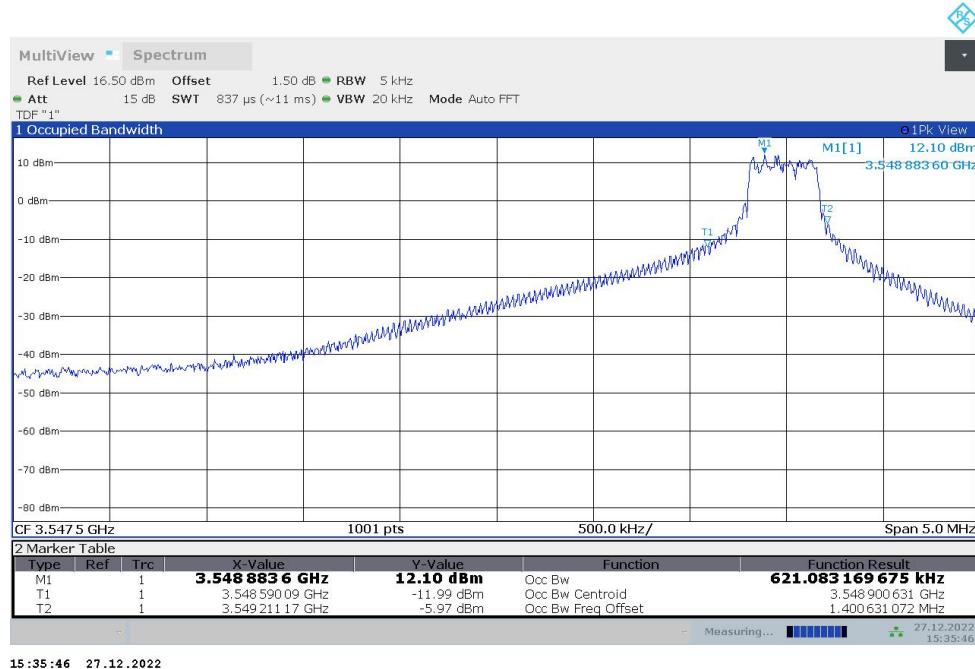
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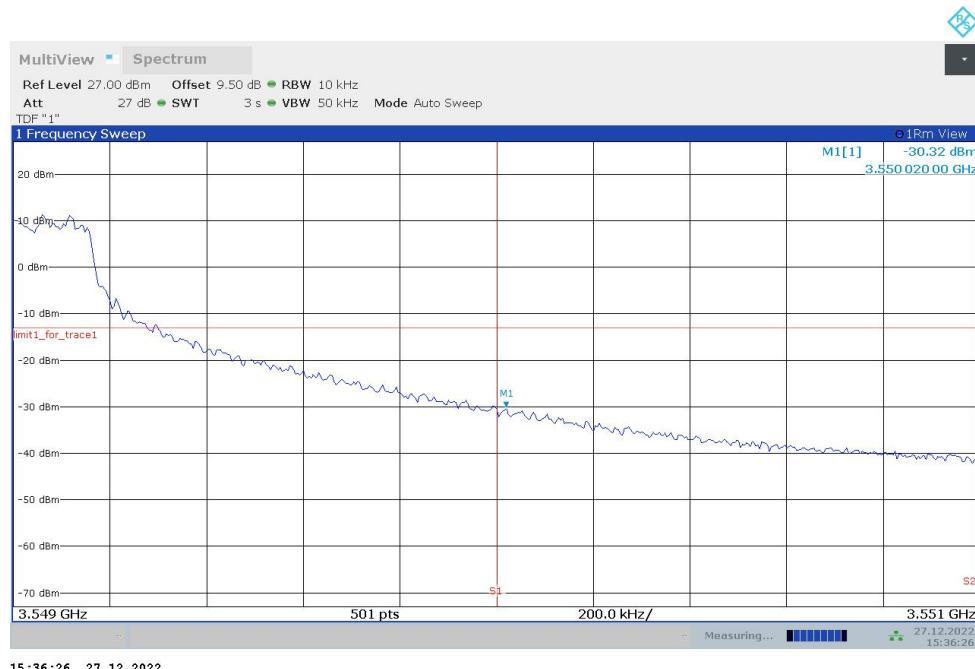
LOW BAND EDGE BLOCK-1RB-LOW_offset



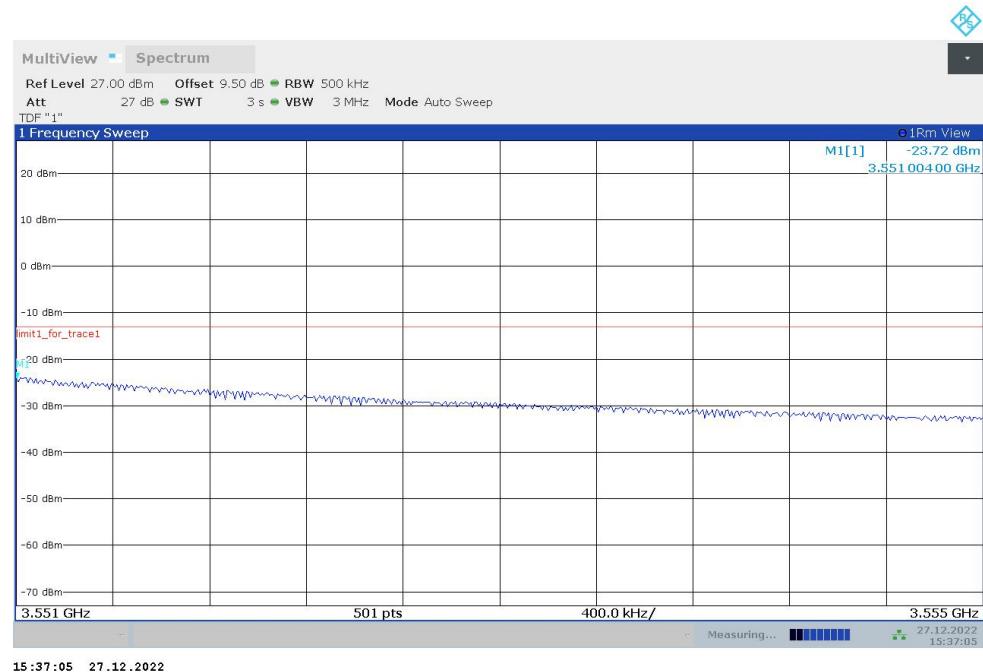
OBW: 1RB-HIGH_offset



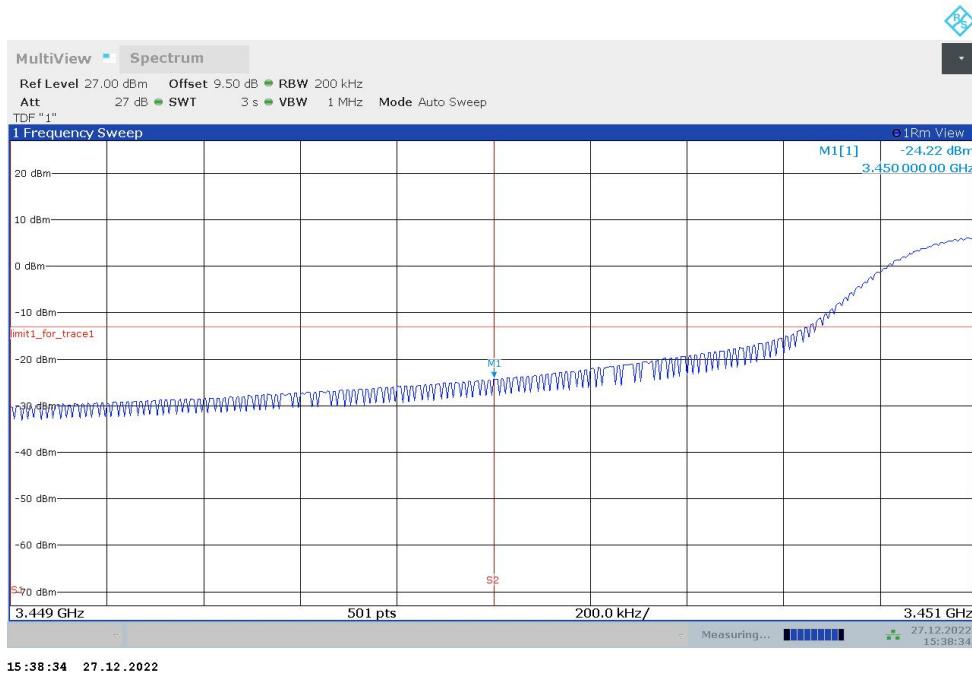
HIGH BAND EDGE BLOCK-1RB-HIGH_offset



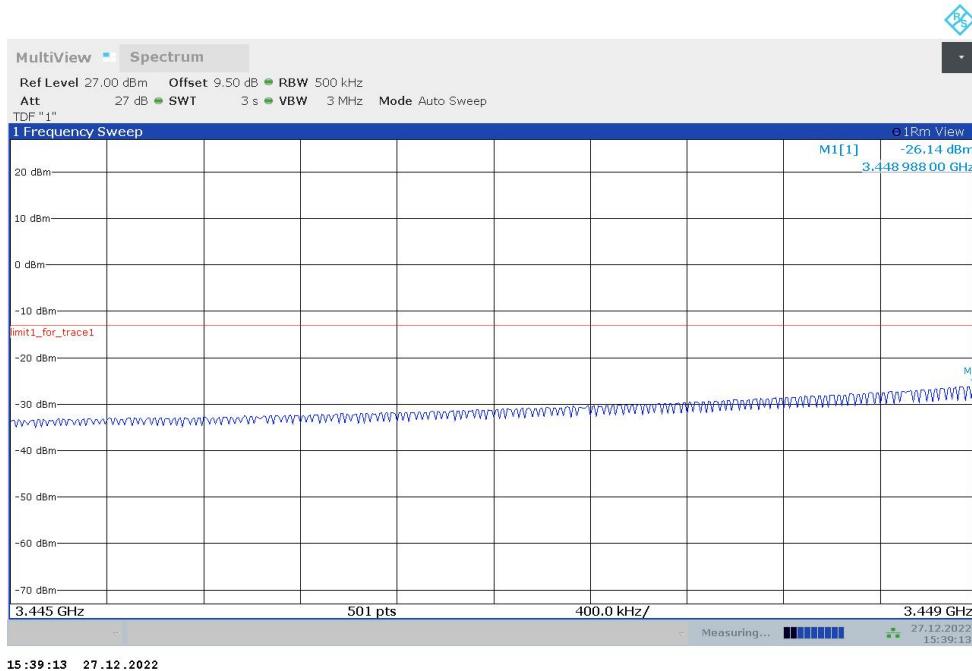
HIGH BAND EDGE BLOCK-1RB-HIGH_offset



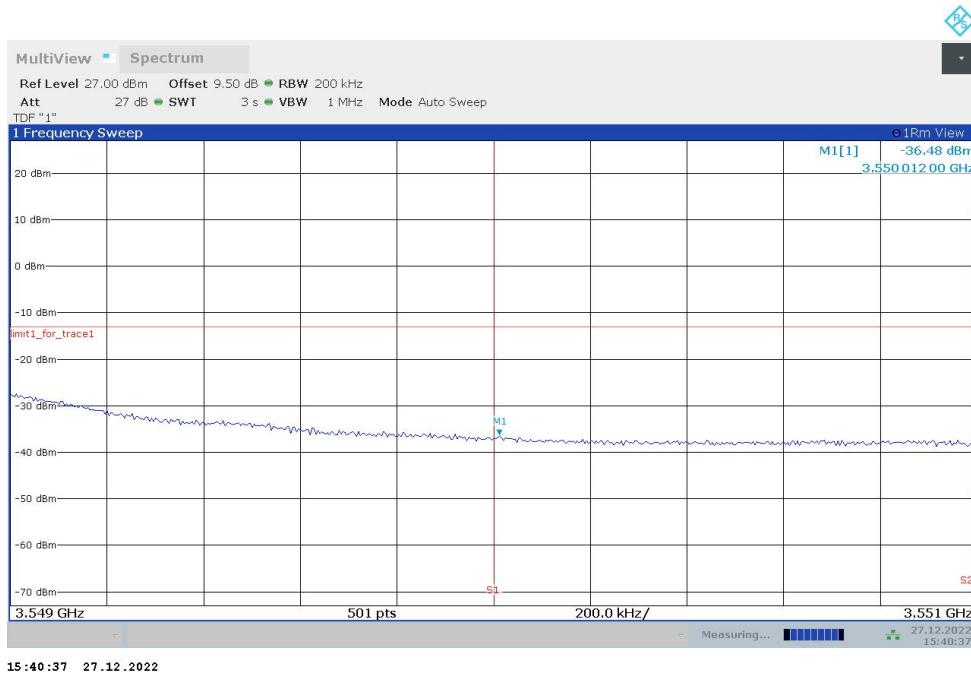
LOW BAND EDGE BLOCK-90M-100%RB



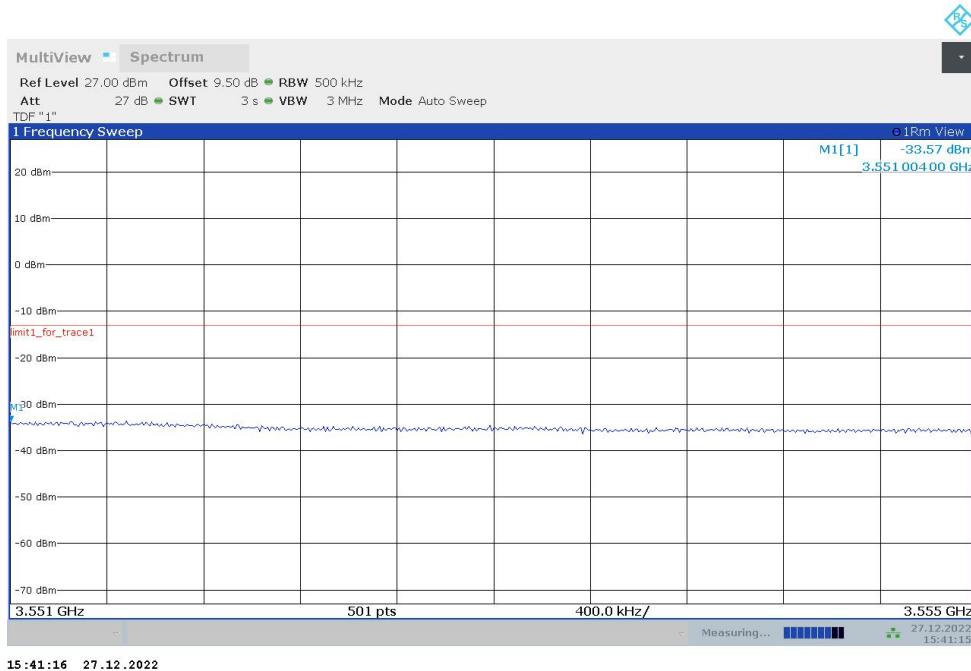
LOW BAND EDGE BLOCK-90M-100%RB

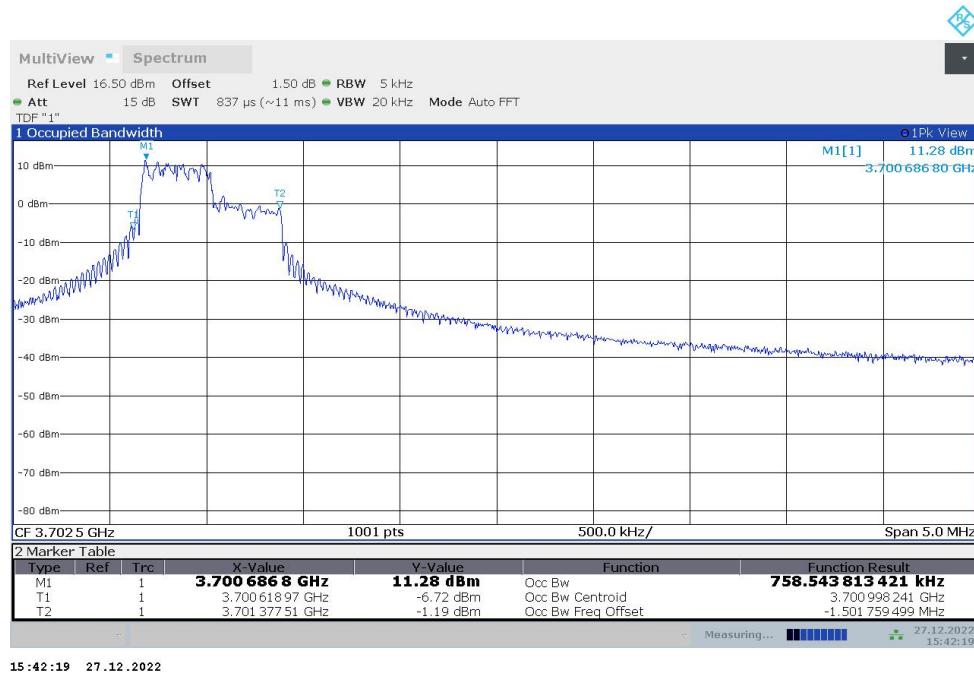
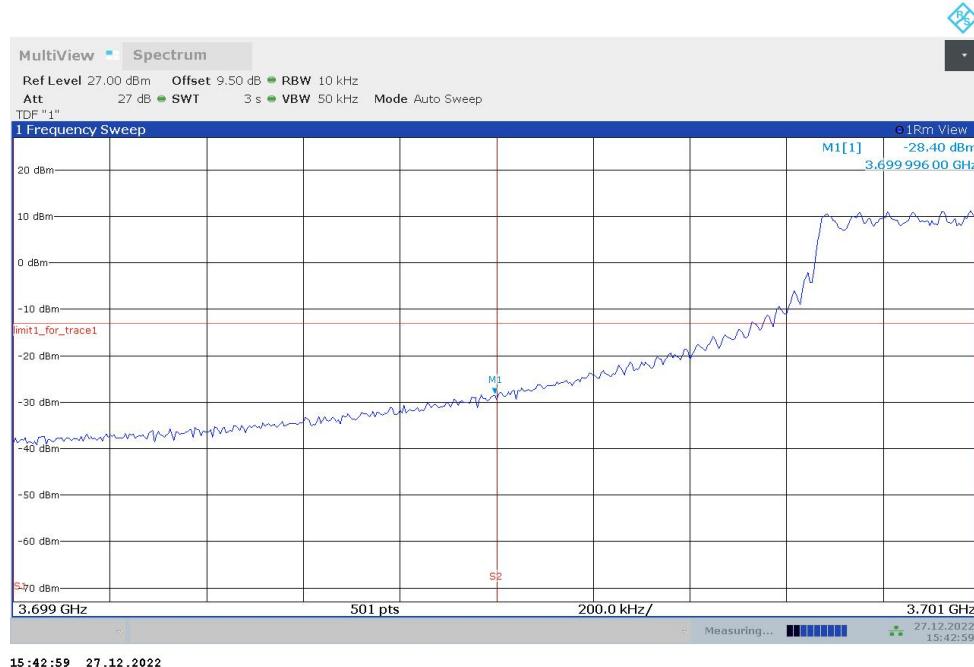


HIGH BAND EDGE BLOCK-90M-100%RB

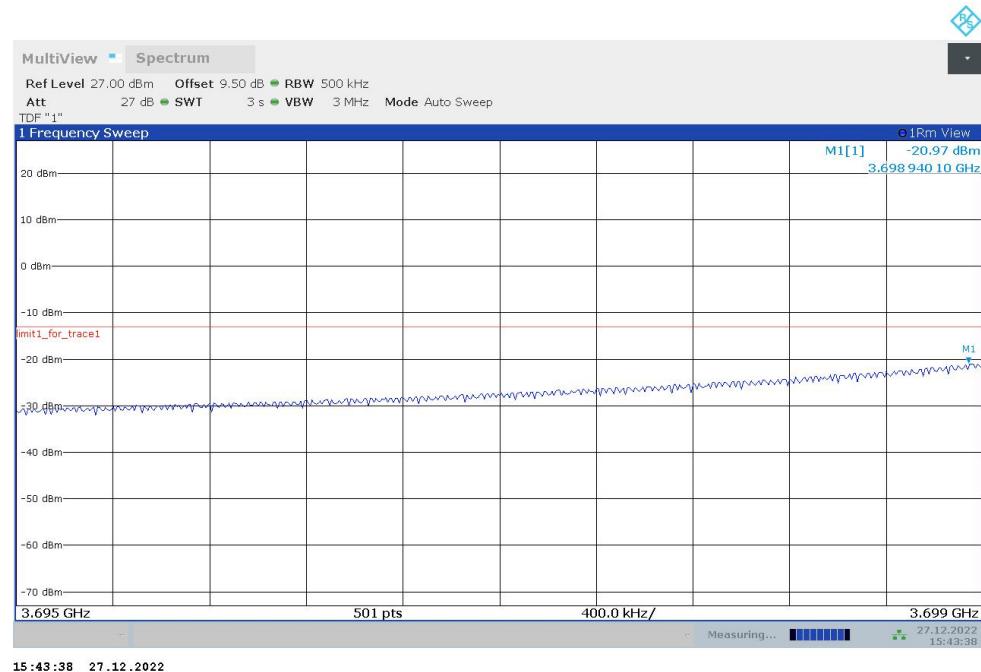


HIGH BAND EDGE BLOCK-90M-100%RB

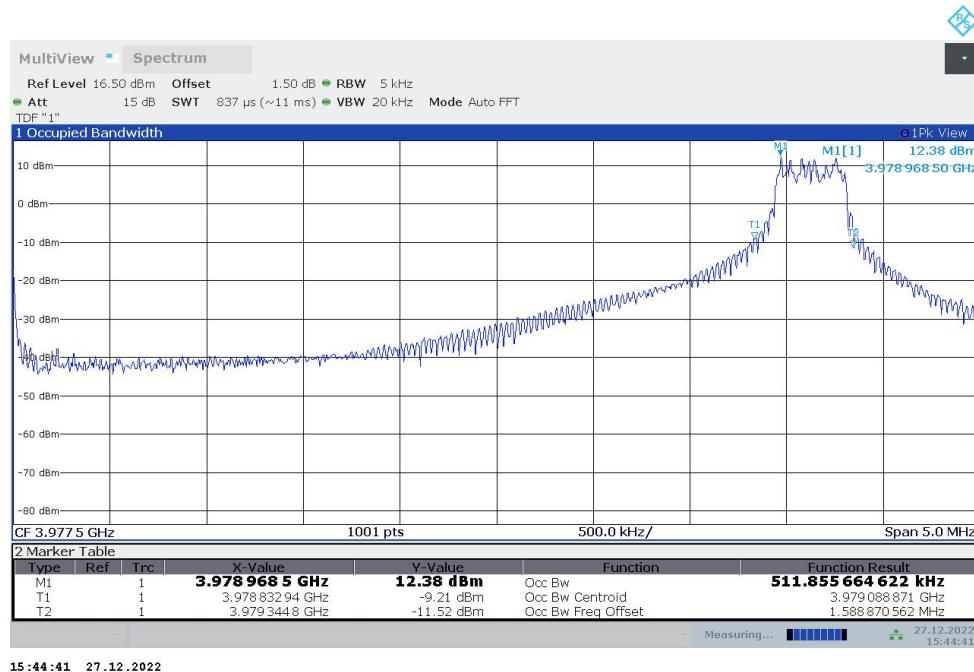


LTE Band 66+NR n77H
OBW: 1RB-LOW_offset

LOW BAND EDGE BLOCK-1RB-LOW_offset


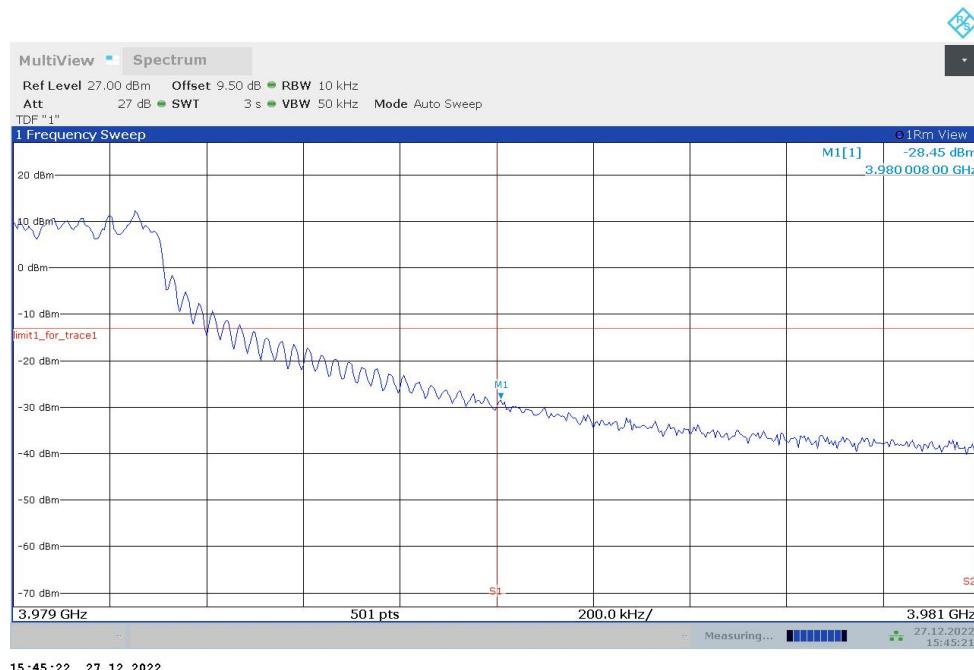
LOW BAND EDGE BLOCK-1RB-LOW_offset



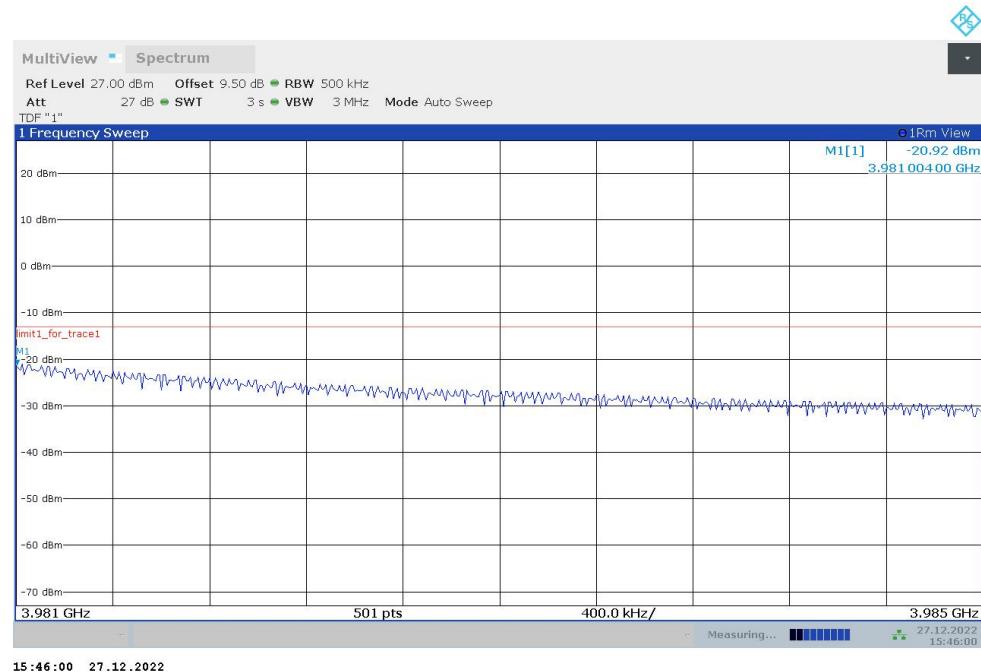
OBW: 1RB-HIGH_offset

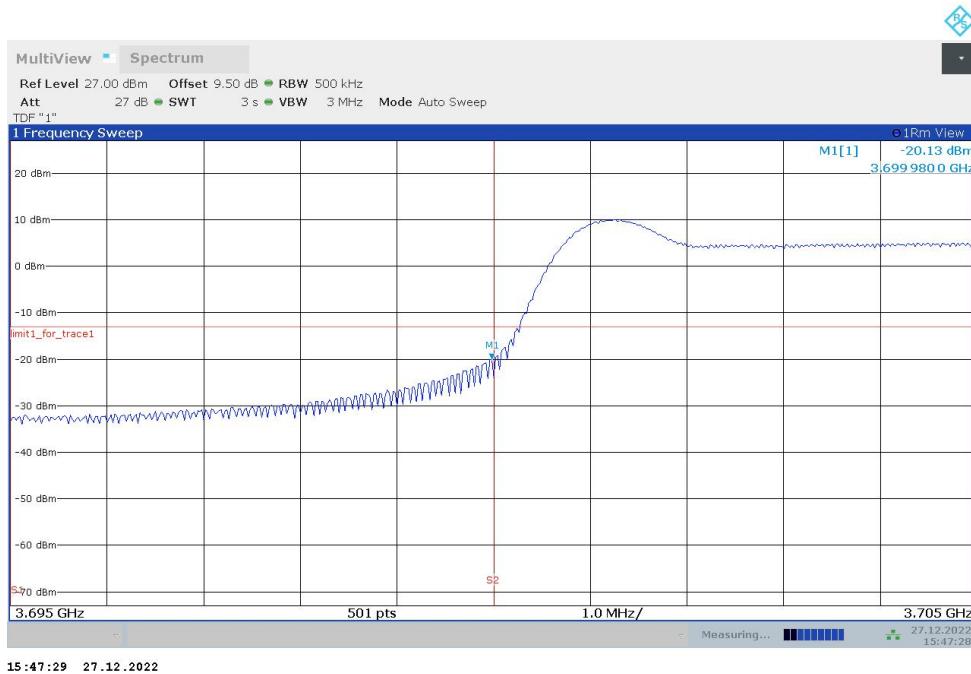
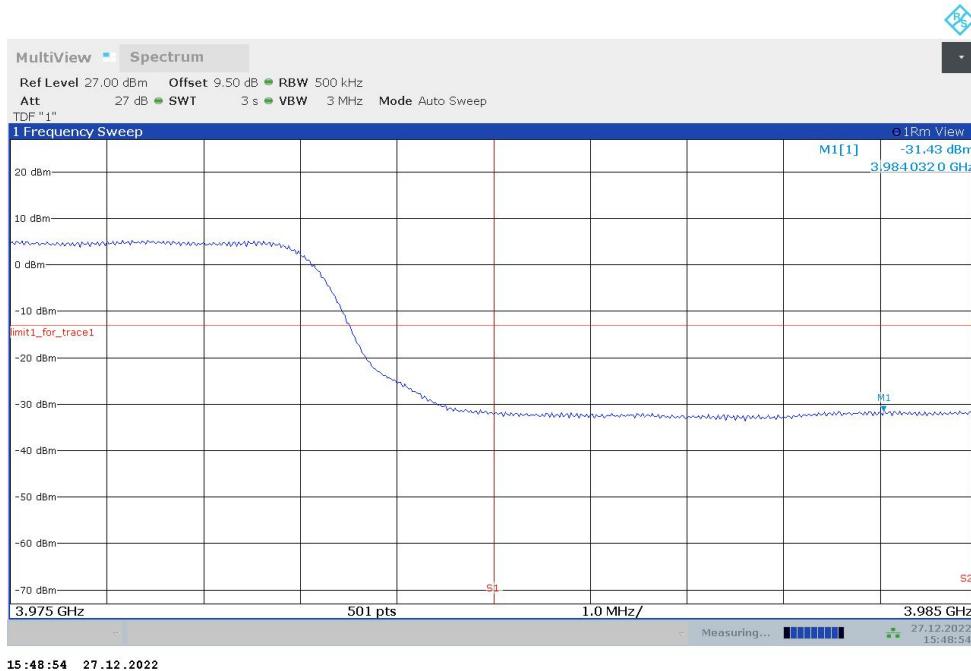


HIGH BAND EDGE BLOCK-1RB-HIGH_offset



HIGH BAND EDGE BLOCK-1RB-HIGH_offset



LOW BAND EDGE BLOCK-100M-100%RB

HIGH BAND EDGE BLOCK-100M-100%RB


Note: The maximum value of expanded measurement uncertainty for this test item is $U = 0.626 \text{ kHz}$, $k = 2$.

A.6 Conducted Spurious Emission

A.6.1 Measurement Method

The following steps outline the procedure used to measure the conducted emissions from the EUT.

1. In measuring unwanted emissions, the spectrum shall be investigated from 30 MHz or the lowest radio frequency signal generated in the equipment, whichever is lower, without going below 9 kHz, up to at least the frequency given below:
 - (a) If the equipment operates below 10 GHz: to the tenth harmonic of the highest fundamental frequency or to 40 GHz, whichever is lower.
 - (b) If the equipment operates at or above 10 GHz: to the fifth harmonic of the highest fundamental frequency or to 100 GHz, whichever is lower.
2. Determine EUT transmit frequencies: below outlines the band edge frequencies pertinent to conducted emissions testing.
3. The number of sweep points of spectrum analyzer is greater than $2 \times \text{span}/\text{RBW}$.

A.6.2 Measurement Limit

Part 22.917, Part 24.238 and Part 27.53(h) specify that the power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least $43 + 10 \log(P)$ dB.

Part 27.53(n) states for mobile operations in the 3450-3550 MHz band, the conducted power of any emission outside the licensee's authorized bandwidth shall not exceed $-13 \text{ dBm}/\text{MHz}$.

Compliance with this paragraph (n)(2) is based on the use of measurement instrumentation employing a resolution bandwidth of 1 megahertz or greater. However, in the 1 megahertz bands immediately outside and adjacent to the licensee's frequency block, a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed, but limited to a maximum of 200 kHz. In the bands between 1 and 5 MHz removed from the licensee's frequency block, the minimum resolution bandwidth for the measurement shall be 500 kHz. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emissions are attenuated at least 26 dB below the transmitter power.

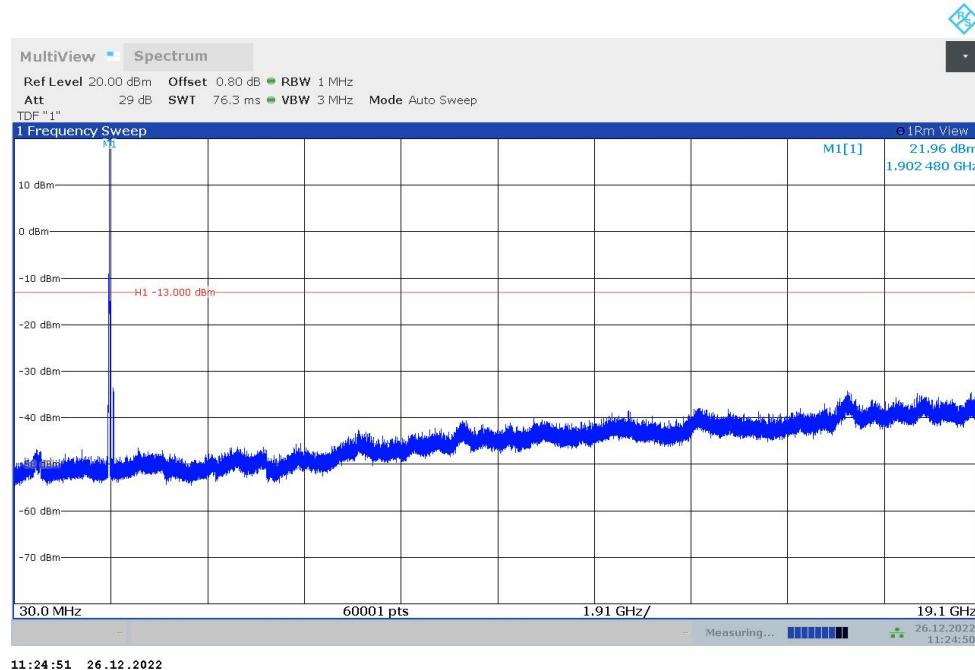
Part 27.53(l) states for mobile operations in the 3700-3980 MHz band, the conducted power of any emission outside the licensee's authorized bandwidth shall not exceed $-13 \text{ dBm}/\text{MHz}$.

Compliance with this paragraph (l)(2) is based on the use of measurement instrumentation employing a resolution bandwidth of 1 megahertz or greater. However, in the 1 megahertz bands immediately outside and adjacent to the licensee's frequency block, the minimum resolution bandwidth for the measurement shall be either one percent of the emission bandwidth of the fundamental emission of the transmitter or 350 kHz. In the bands between 1 and 5 MHz removed from the licensee's frequency block, the minimum resolution bandwidth for the measurement shall be 500 kHz. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emissions are attenuated at least 26 dB below the transmitter power.

A.6.3 Measurement result

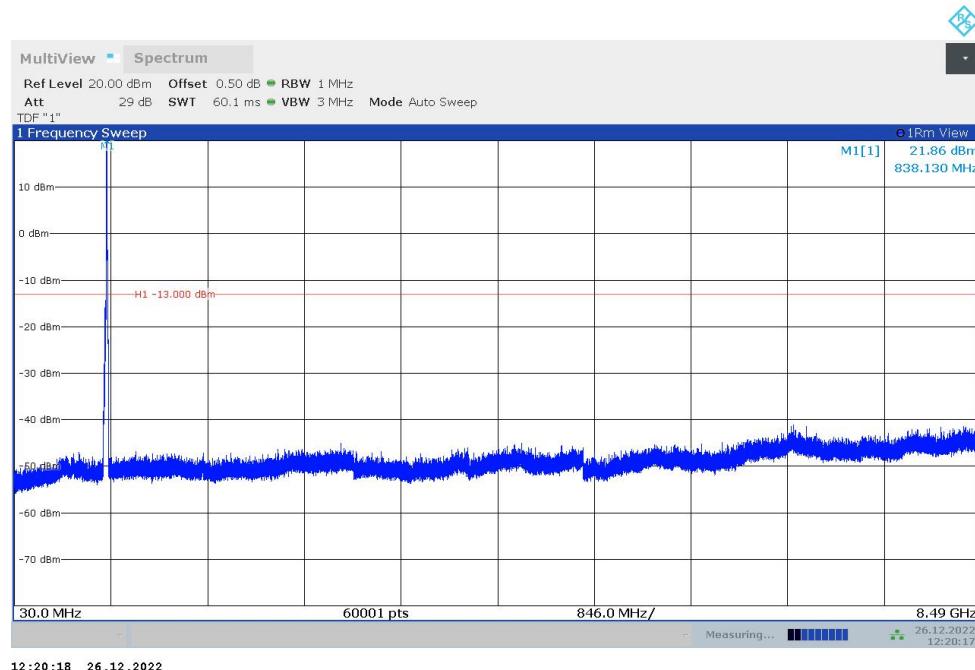
LTE Band 13+NR n2

NOTE: peak above the limit line is the carrier frequency.



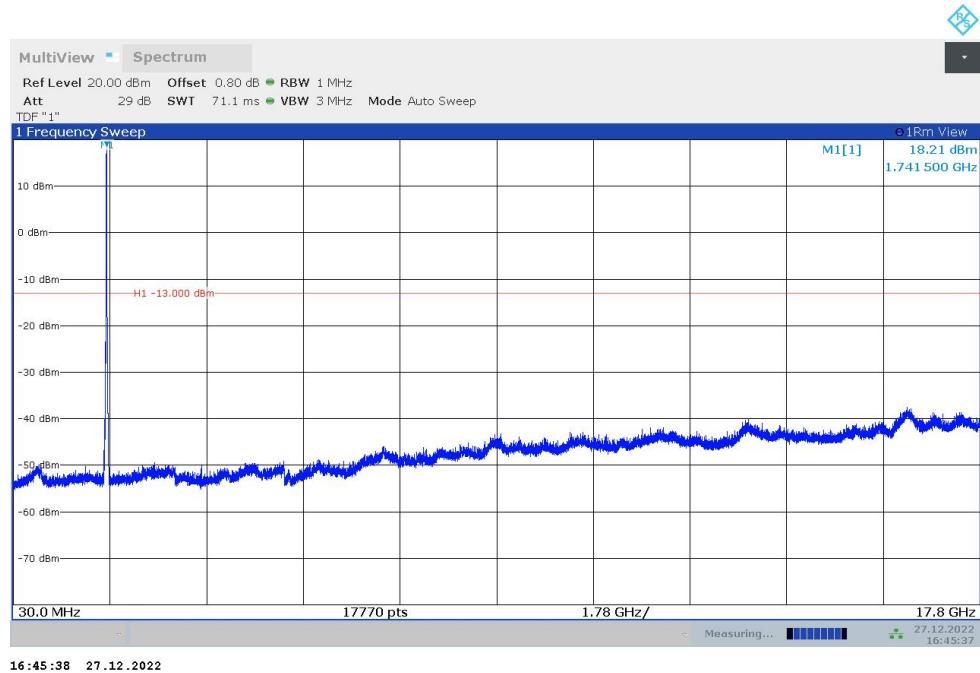
LTE Band 2+NR n5

NOTE: peak above the limit line is the carrier frequency.



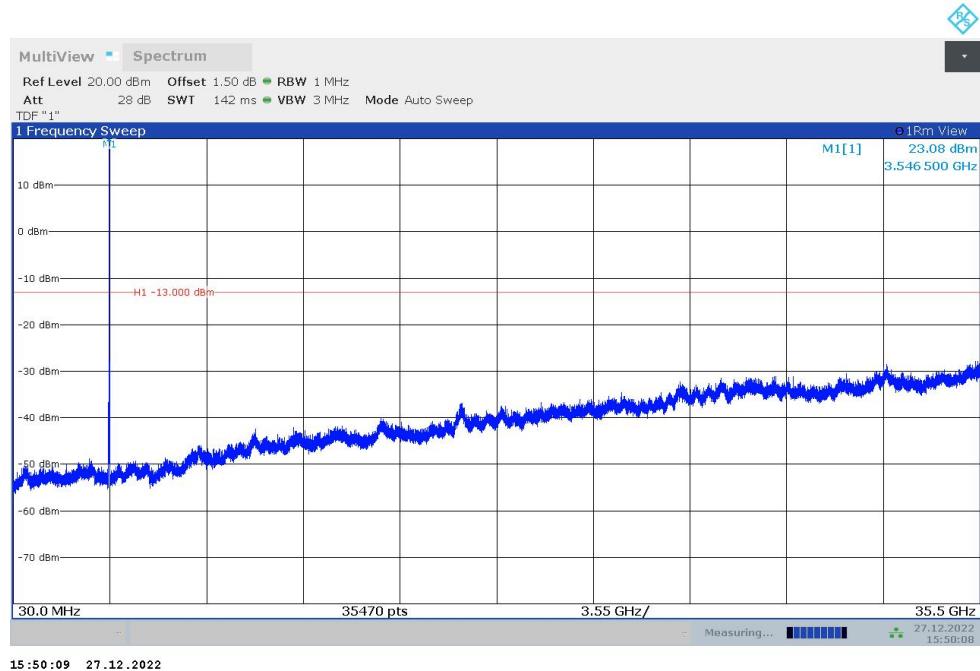
LTE Band 5+NR n66

NOTE: peak above the limit line is the carrier frequency.



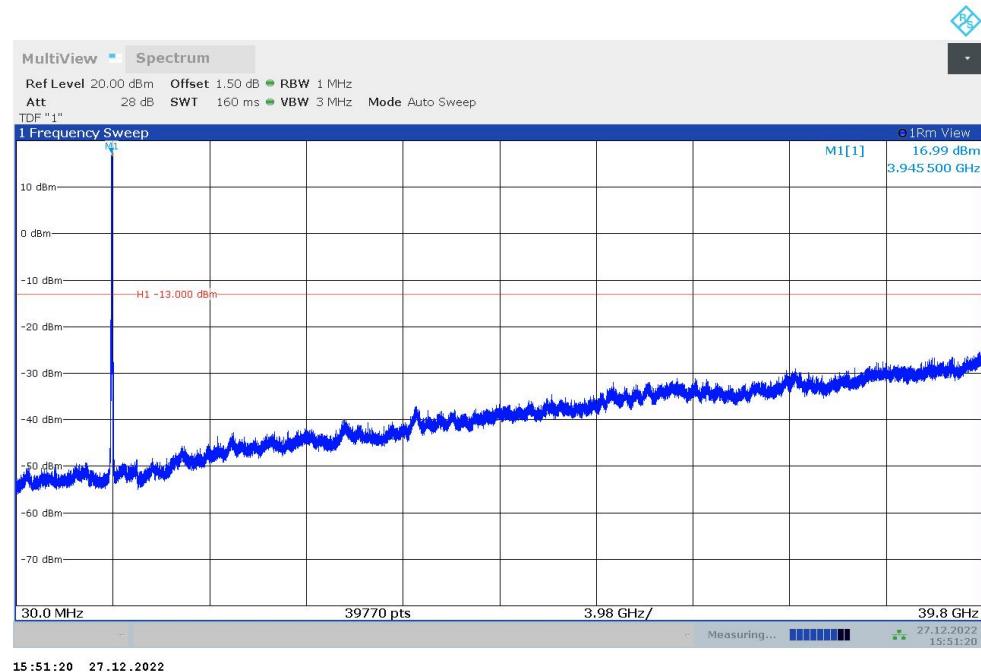
LTE Band 66+NR n77L

NOTE: peak above the limit line is the carrier frequency.



LTE Band 66+NR n77H

NOTE: peak above the limit line is the carrier frequency.



Note: The maximum value of expanded measurement uncertainty for this test item is $U = 0.372 \text{ dB}$, $k = 2$.

A.7 Peak-to-Average Power Ratio

The peak-to-average ratio (PAR) of the transmission may not exceed 13 dB

- Refer to instrument's analyzer instruction manual for details on how to use the power statistics/CCDF function;
- Set resolution/measurement bandwidth \geq signal's occupied bandwidth;
- Set the number of counts to a value that stabilizes the measured CCDF curve;
- Record the maximum PAPR level associated with a probability of 0.1%.

Measurement results

LTE Band 13+NR n2,20MHz

Frequency (MHz)	PAPR (dB)								
	DFT-s-pi/2 BPSK	DFT-s-QPSK	DFT-s-16QAM	DFT-s-64QAM	DFT-s-256QAM	CP-QPSK	CP-16QAM	CP-64QAM	CP-256QAM
1880	5.06	6.50	6.88	7.36	7.44	8.90	8.82	8.80	9.14

LTE Band 5+NR n66,40MHz

Frequency (MHz)	PAPR (dB)								
	DFT-s-pi/2 BPSK	DFT-s-QPSK	DFT-s-16QAM	DFT-s-64QAM	DFT-s-256QAM	CP-QPSK	CP-16QAM	CP-64QAM	CP-256QAM
1745	6.00	6.37	7.15	7.29	7.52	8.88	8.94	9.01	9.36

LTE Band 66+NR n77L,90MHz

Frequency (MHz)	PAPR (dB)								
	DFT-s-pi/2 BPSK	DFT-s-QPSK	DFT-s-16QAM	DFT-s-64QAM	DFT-s-256QAM	CP-QPSK	CP-16QAM	CP-64QAM	CP-256QAM
3500.01	5.28	6.18	6.87	7.07	7.75	8.59	8.62	8.72	10.70

LTE Band 66+NR n77H,100MHz

Frequency (MHz)	PAPR (dB)								
	DFT-s-pi/2 BPSK	DFT-s-QPSK	DFT-s-16QAM	DFT-s-64QAM	DFT-s-256QAM	CP-QPSK	CP-16QAM	CP-64QAM	CP-256QAM
3840	5.40	5.64	7.09	7.30	7.87	9.03	8.98	9.07	9.21

Note: The maximum value of expanded measurement uncertainty for this test item is $U = 0.356$ dB, $k = 2$.

Annex B: Accreditation Certificate

United States Department of Commerce
National Institute of Standards and Technology



Certificate of Accreditation to ISO/IEC 17025:2017

NVLAP LAB CODE: 600118-0

Telecommunication Technology Labs, CAICT

Beijing
China

*is accredited by the National Voluntary Laboratory Accreditation Program for specific services,
listed on the Scope of Accreditation, for:*

Electromagnetic Compatibility & Telecommunications

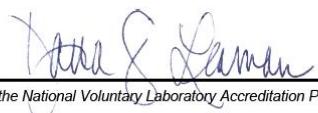
*This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2017.
This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality
management system (refer to joint ISO-ILAC-IAF Communiqué dated January 2009).*

2022-10-01 through 2023-09-30

Effective Dates



For the National Voluntary Laboratory Accreditation Program



*****END OF REPORT*****